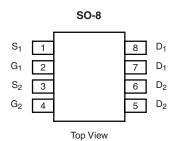




Dual N-Channel 60-V (D-S) 175 °C MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A)	Q _g (Typ.)		
60	0.041 at V _{GS} = 10 V	6.5	9.2 nC		
	0.052 at V _{GS} = 4.5 V	5.8	9.2110		



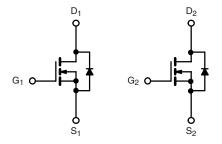
Ordering Information: Si4946BEY-T1-E3 (Lead (Pb)-free)

Si4946BEY-T1-GE3 (Lead (Pb)-free and Halogen-free)

FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET[®] Power MOSFET
- 175 °C Maximum Junction Temperature
- 100 % R_q Tested
- Compliant to RoHS directive 2002/95/EC





N-Channel MOSFET

N-Channel MOSFET

Parameter		Symbol	Limit	Unit
Drain-Source Voltage	V _{DS}	60	V	
Gate-Source Voltage		V _{GS}		± 20
	T _C = 25 °C		6.5	
Continuous Prain Current (T. 150 °C)	T _C = 70 °C		5.5	
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	I _D	5.3 ^{a, b}	
	T _A = 70 °C		4.4 ^{a, b}	
Pulsed Drain Current		I _{DM}	30	A .
Continuous Course Brain Binds Courset	T _C = 25 °C		3.1	
Continuous Source Drain Diode Current	T _A = 25 °C	I _S	2 ^{a, b}	
Avalanche Current	1 01 mll	I _{AS}	12	
Single-Pulse Avalanche Energy	L = 0 1 mH	E _{AS}	7.2	mJ
	T _C = 25 °C		3.7	
Maximum Power Dissipation	T _C = 70 °C	В	2.6	\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\
	T _A = 25 °C	P _D	2.4 ^{a, b}	W
	T _A = 70 °C		1.7 ^{a, b}	
Operating Junction and Storage Temperature R	T _J , T _{stg}	- 55 to 175	°C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{a, c}	t ≤ 10 s	R _{thJA}	50	62.5	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R _{thJF}	33	41	C/VV	

Notes:

- a. Surface Mounted on 1" x 1" FR4 board.
- b. t = 10 s.
- c. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.
- d. Maximum under Steady State conditions is 110 °C/W.

Si4946BEY

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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static					•		
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	60			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	L = 250 uA		53			
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_{J}$	I _D = 250 μA		- 6.7		mV/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1.0	2.4	3.0	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current		V _{DS} = 60 V, V _{GS} = 0 V			1	_	
	I _{DSS}	V _{DS} = 60 V, V _{GS} = 0 V, T _J = 55 °C			10	μΑ	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	30			Α	
		$V_{GS} = 10 \text{ V}, I_D = 5.3 \text{ A}$	 		0.041	+	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 4.5 V, I _D = 4.7 A		0.041	0.052	Ω	
Forward Transconductance ^a	g _{fs}	V _{DS} = 15 V, I _D = 5.3 A		24		S	
Dynamic ^b	<u> </u>			<u> </u>		1	
Input Capacitance	C _{iss}			840		pF	
Output Capacitance	C _{oss}	V _{DS} = 30 V, V _{GS} = 0 V, f = 1 MHz		71			
Reverse Transfer Capacitance	C _{rss}			44			
	Qg	$V_{DS} = 30 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 5.3 \text{ A}$		17	25		
Total Gate Charge				9.2	12	nC	
Gate-Source Charge	Q _{gs}	$V_{DS} = 30 \text{ V}, V_{GS} = 5 \text{ V}, I_{D} = 5.3 \text{ A}$		3.3			
Gate-Drain Charge	Q_{gd}			3.7			
Gate Resistance	R_g	f = 1 MHz	3.1	6.5	9.5	Ω	
Turn-On Delay Time	t _{d(on)}			20	30		
Rise Time	t _r	$V_{DD} = 30 \text{ V}, R_{L} = 6.8 \Omega$		120	180	1	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 4.4 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		20	30	1	
Fall Time	t _f			30	45		
Turn-On Delay Time	t _{d(on)}			10	15	- ns -	
Rise Time	t _r	V_{DD} = 30 V, R_L = 6.8 Ω		12	20		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 4.4 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		25	40		
Fall Time	t _f			10	15	1	
Drain-Source Body Diode Characteris	tics	-		•		•	
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			3.1	Λ	
Pulse Diode Forward Current ^a	I _{SM}				30	A	
Body Diode Voltage	V_{SD}	I _S = 2 A		0.8	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			25	50	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = 4.4 A, dl/dt = 100 A/μs, T _{.l} = 25 °C		25	50	nC	
Reverse Recovery Fall Time	t _a	$I_F = 4.4 \text{ A}, \text{ u/u} = 100 \text{ A/}\mu\text{s}, I_J = 25 ^{\circ}\text{C}$		18			
Reverse Recovery Rise Time	t _b			7		ns	

Notes:

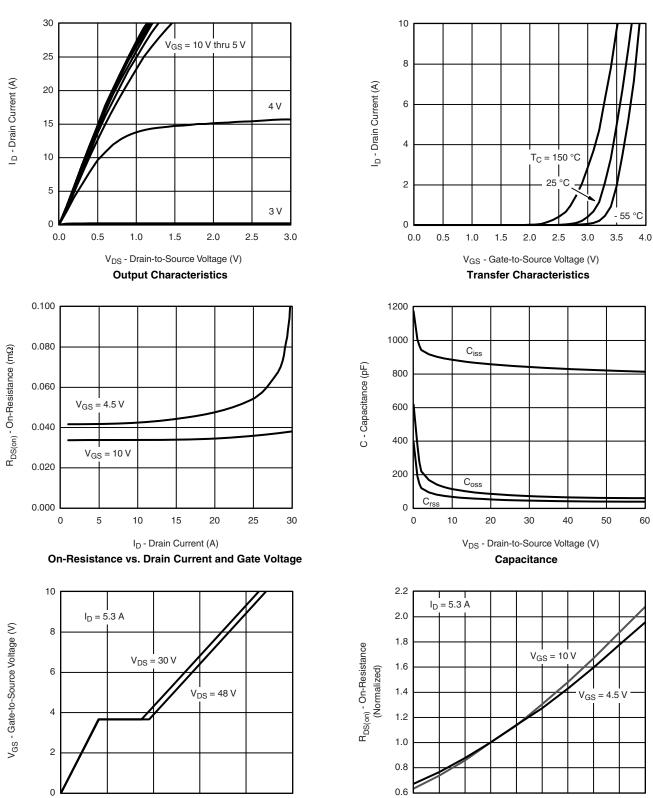
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$

b. Guaranteed by design, not subject to production testing.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



- 25 0

25 50 75 100

T_J - Junction Temperature (°C)

On-Resistance vs. Junction Temperature

- 50

0

4

12

Q_g - Total Gate Charge (nC)

Gate Charge

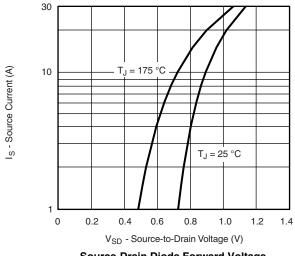
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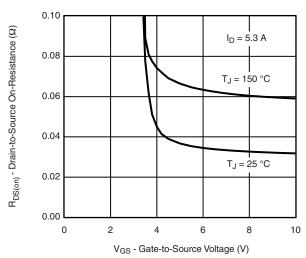
20

125 150 175

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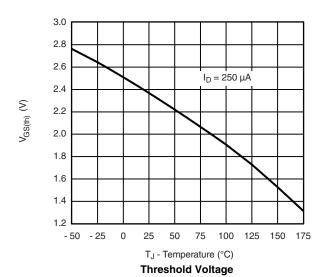
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

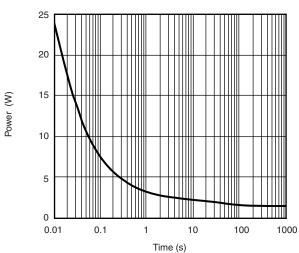




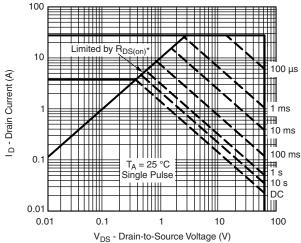
Source-Drain Diode Forward Voltage







Single Pulse Power, Junction-to-Ambient

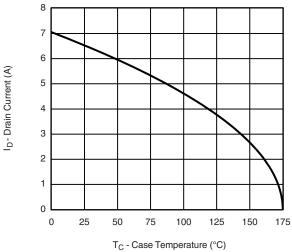


* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

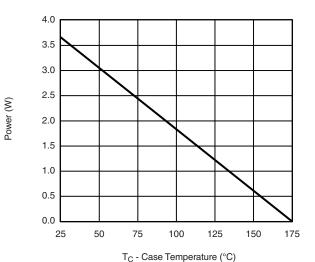
Safe Operating Area, Junction-to-Ambient



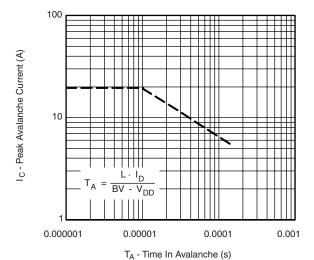
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Current Derating*



Power, Junction-to-Case



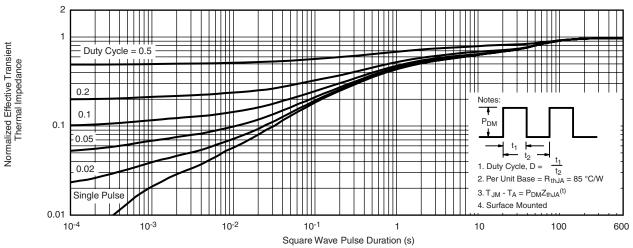
Single Pulse Avalanche Capability

^{*} The power dissipation P_D is based on $T_{J(max)} = 175$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

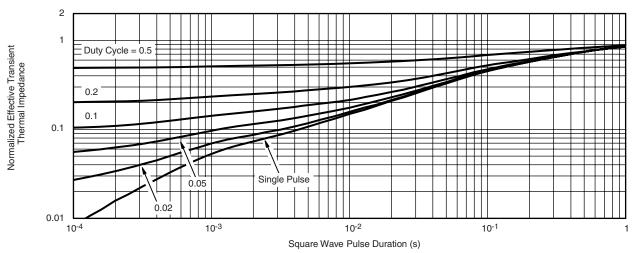
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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SOIC (NARROW): 8-LEAD JEDEC Part Number: MS-012







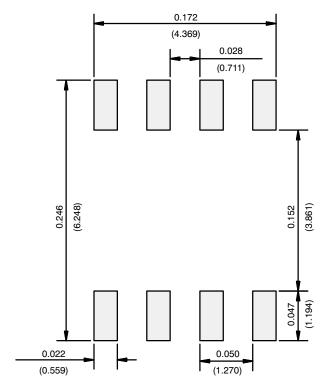
	MILLIMETERS INCHES			HES		
DIM	Min	Max	Min	Max		
Α	1.35	1.75	0.053	0.069		
A ₁	0.10	0.20	0.004	0.008		
В	0.35	0.51	0.014	0.020		
С	0.19	0.25	0.0075	0.010		
D	4.80	5.00	0.189	0.196		
Е	3.80	4.00	0.150	0.157		
е	1.27	BSC	0.050 BSC			
Н	5.80	6.20	0.228	0.244		
h	0.25	0.50	0.010	0.020		
L	0.50	0.93	0.020	0.037		
q	0°	8°	0°	8°		
S	0.44	0.64	0.018	0.026		
ECN: C-06527-Rev. I. 11-Sep-06						

DWG: 5498

Document Number: 71192 www.vishay.com 11-Sep-06



RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)

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